Feb./2007

MITSUBISHI SEMICONDUTOR <GaAs FET> MGF4961B

SUPER LOW NOISE InGaAs HEMT

DESCRIPTION

The MGF4961B super-low noise HEMT (High Electron Mobility Transistor) is designed for use in K band amplifiers.

FEATURES

Low noise figure @ f=20GHz NFmin. = 0.7dB (Typ.)

High associated gain @ f=20GHz Gs = 13.5dB (Typ.)

APPLICATION

C to K band low noise amplifiers

QUALITY GRADE

GG

RECOMMENDED BIAS CONDITIONS

 V_{DS} =2V , I_{D} =10mA

Symbol

V_{GDO}

V_{GSO}

 I_D

PT

T_{ch}

Tstg

ORDERING INFORMATION

ABSOLUTE MAXIMUM RATINGS

Tape & reel 4000pcs./reel

MITSUBISHI Proprietary

(Ta=25°C)

Ratings

-4

-4

IDSS

50

125

-55 to +125

Not to be reproduced or disclosed without permission by Mitsubishi Electric

Unit

V

V

mΑ

mW

°C

°C

Keep Safety first in your circuit designs! Mitsubishi Electric Corporation puts the maximum effort into making semiconductor products better and more reliable, but there is always the possibility that trouble may occur with them. Trouble with semiconductors may lead to personal injury, fire or property damage. Remember to give due consideration to safety when making your circuit designs, with appropriate measure such as (I) placement of substitutive, auxiliary circuits, (ii) use of non-flammable material or (iii) prevention against any malfunction or mishap.

ELECTRICAL CHARACTERISTICS (Ta=25°C)

Drain current

Parameter

Gate to drain voltage

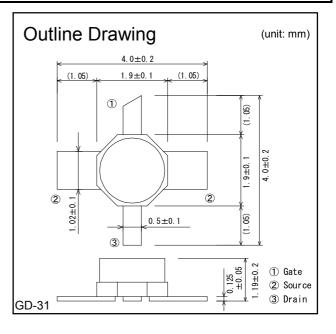
Gate to source voltage

Total power dissipation

Channel temperature

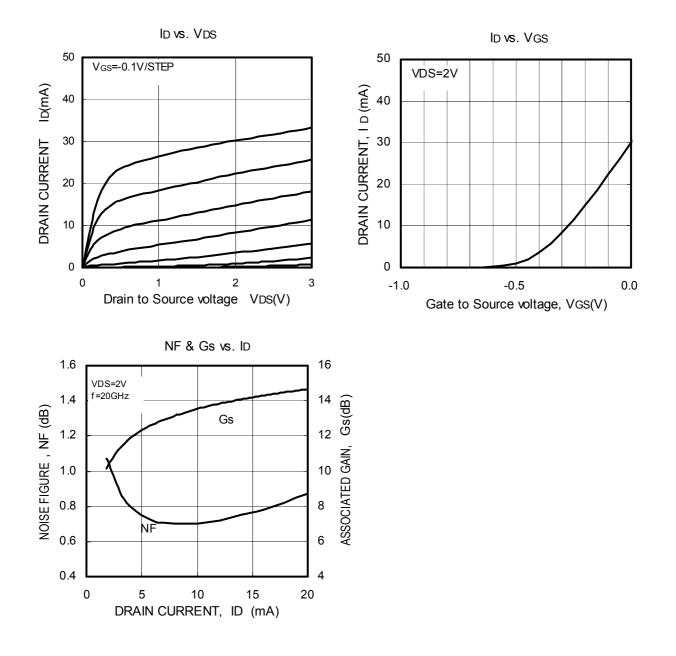
Storage temperature

Synbol	Parameter	Test conditions	Limits			Unit
			MIN.	TYP.	MAX	
V _{(BR)GDO}	Gate to drain breakdown voltage	I _G =-10μA	-3			V
I _{GSS}	Gate to source leakage current	V _{GS} =-2V,V _{DS} =0V			50	μA
I _{DSS}	Saturated drain current	V _{GS} =0V,V _{DS} =2V	15		60	mA
V _{GS(off)}	Gate to source cut-off voltage	V _{DS} =2V,I _D =500μA	-0.1		-1.5	V
Gs	Associated gain	V _{DS} =2V,I _D =10mA	11.5	13.5		dB
NFmin.	Minimum noise figure	f=20GHz		0.70	0.95	dB



SUPER LOW NOISE InGaAs HEMT

TYPICAL CHARACTERISTICS (Ta=25°C)



MITSUBISHI

SUPER LOW NOISE InGaAs HEMT

S PARAMETERS

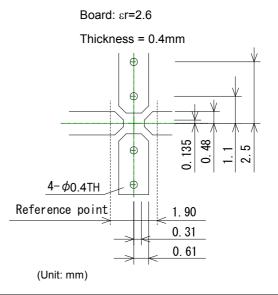
AMETE	METERS (Ta=25°C,VDS=2V,ID=10mA)							nA)
Freq.	S11		S21		S12		S22	
(GHz)	(mag)	(ang)	(mag)	(ang)	(mag)	(ang)	(mag)	(ang)
1	0.991	-16.4	4.743	162.8	0.015	76.9	0.658	-13.0
2	0.967	-32.5	4.652	146.3	0.028	66.2	0.643	-25.8
3	0.928	-48.5	4.525	129.9	0.041	54.8	0.622	-38.9
4	0.886	-64.5	4.403	113.8	0.052	43.4	0.596	-51.4
5	0.835	-80.3	4.252	98.3	0.059	33.1	0.571	-63.0
6	0.782	-98.8	4.089	81.6	0.065	21.3	0.541	-76.5
7	0.729	-115.0	3.885	66.6	0.068	11.7	0.517	-87.6
8	0.682	-130.4	3.665	52.2	0.067	2.6	0.492	-98.0
9	0.637	-145.0	3.437	39.2	0.066	-6.2	0.474	-106.1
10	0.563	-155.8	3.265	28.3	0.063	-15.5	0.461	-116.0
11	0.536	-165.2	3.248	17.1	0.051	-21.9	0.461	-121.0
12	0.527	-175.0	3.266	5.0	0.043	-19.3	0.479	-128.9
13	0.520	172.8	3.303	-8.4	0.047	-17.7	0.480	-139.8
14	0.509	160.4	3.422	-21.6	0.047	-15.3	0.487	-147.7
15	0.474	145.5	3.542	-36.3	0.044	-19.1	0.489	-157.0
16	0.459	129.1	3.659	-52.3	0.052	-15.0	0.482	-167.4
17	0.449	104.5	3.881	-68.5	0.058	-26.7	0.488	-177.8
18	0.445	74.9	4.101	-89.4	0.062	-44.4	0.473	164.4
19	0.473	40.8	4.063	-111.4	0.059	-68.0	0.402	143.4
20	0.534	8.1	3.940	-134.0	0.052	-93.8	0.325	118.7
21	0.597	-21.4	3.685	-157.2	0.050	-125.1	0.251	86.6
22	0.657	-44.1	3.324	179.7	0.046	-155.7	0.198	46.3
23	0.695	-64.0	2.969	158.8	0.058	169.5	0.216	3.2
24	0.696	-79.4	2.570	138.3	0.065	148.6	0.247	-27.3
25	0.686	-93.5	2.294	119.4	0.082	128.7	0.289	-45.2
26	0.656	-105.2	2.038	100.1	0.095	118.8	0.346	-56.5

NOISE PARAMETERS (VDS=2V,ID=10mA, Ta=25°C)

Freq.	Гopt		Rn	NFmin
(GHz)	(mag)	(ang)		(dB)
12	0.525	144.8	0.08	0.43
13	0.462	166.2	0.09	0.47
14	0.403	-174.0	0.11	0.51
15	0.348	-155.5	0.12	0.55
16	0.297	-138.3	0.13	0.58
17	0.249	-122.1	0.14	0.61
18	0.204	-106.8	0.15	0.64
19	0.186	-72.3	0.19	0.67
20	0.168	-39.5	0.23	0.70
21	0.223	-14.6	0.29	0.80
22	0.276	17.5	0.35	0.89
23	0.296	36.8	0.39	0.97
24	0.315	55.2	0.43	1.05
25	0.333	72.9	0.47	1.13
26	0.350	89.9	0.51	1.20

Note) Rn is normalized by 50ohm

S parameter measurement:



MITSUBISHI

Requests Regarding Safety Designs

Mitsubishi Electric constantly strives to raise the level of its quality and reliability. Despite these concerted efforts, however, there will be occasions when our semiconductor products suffer breakdowns, malfunctions or other problems. In view of this reality, it is requested that every feasible precaution be taken in the pursuit of redundancy design, malfunction prevention design and other safety-related designs, to prevent breakdowns or malfunctions in our products from resulting in accidents involving people, fires, social losses or other problems, thereby upholding the highest levels of safety in the products when in use by customers.

Matters of Importance when Using these Materials

- 1. These materials are designed as reference materials to ensure that all customers purchase Mitsubishi Electric semiconductors best suited to their specific use applications. Please be aware, however, that the technical information contained in these materials does not comprise consent for the execution or use of intellectual property rights or other rights owned by Mitsubishi Electric Corporation.
- 2. Mitsubishi Electric does not assume responsibility for damages resulting from the use of product data, graphs, charts, programs, algorithms or other applied circuit examples described in these materials, or for the infringement of the rights of third-party owners resulting from such use.
- 3. The data, graphs, charts, programs, algorithms and all other information described in these materials were current at the issue of these materials, with Mitsubishi Electric reserving the right to make any necessary updates or changes in the products or specifications in these materials without prior notice. Before purchasing Mitsubishi Electric semiconductor products, therefore, please obtain the latest available information from Mitsubishi Electric directly or an authorized dealer.
- 4. Every possible effort has been made to ensure that the information described in these materials is fully accurate. However, Mitsubishi Electric assumes no responsibility for damages resulting from inaccuracies occurring within these materials.
- 5. When using the product data, technical contents indicated on the graphs, charts, programs or algorithms described in these materials, assessments should not be limited to only the technical contents, programs and algorithm units. Rather, it is requested that ample evaluations be made of each individual system as a whole, with the customer assuming full responsibility for decisions on the propriety of application. Mitsubishi Electric does not accept responsibility for the propriety of application.
- 6. The products described in these materials, with the exception of special mention concerning use and reliability, have been designed and manufactured with the purpose of use in general electronic machinery. Accordingly these products have not been designed and manufactured with the purpose of application in machinery or systems that will be used under conditions that can affect human life, or in machinery or systems used in social infrastructure that demand a particularly high degree of reliability. When considering the use of the products described in these materials in transportation machinery (automobiles, trains, vessels), for objectives related to medical treatment, aerospace, nuclear power control, submarine repeaters or systems or other specialized applications, please consult with Mitsubishi Electric directly or an authorized dealer.
- 7. When considering use of products for purposes other than the specific applications described in these materials, please inquire at Mitsubishi Electric or an authorized dealer.
- 8. The prior consent of Mitsubishi Electric in writing is required for any reprinting or reproduction of these materials.
- 9. Please direct any inquiries regarding further details of these materials, or any other comments or matters of attention, to Mitsubishi Electric or an authorized dealer.

MITSUBISHI